MOSFET – SiC Power, Single N-Channel, TO247-4L

1200 V, 40 mΩ, 58 A

NTH4L040N120SC1

Features

- Typ. $R_{DS(on)} = 40 \text{ m}\Omega$
- Ultra Low Gate Charge ($Q_{G(tot)} = 106 \text{ nC}$)
- High Speed Switching with Low Capacitance ($C_{oss} = 137 \text{ pF}$)
- 100% Avalanche Tested
- $T_J = 175^{\circ}C$
- This Device is Pb-Free and is RoHS Compliant

Typical Applications

- UPS
- DC/DC Converter
- Boost Inverter

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	1200	V
Gate-to-Source Voltage			V _{GS}	-15/+25	V
Recommended Operatio of Gate-to-Source Volta		T _C < 175°C	V _{GSop}	-5/+20	V
Continuous Drain Current (Note 2)	Steady State	$T_{C} = 25^{\circ}C$	۱ _D	58	A
Power Dissipation (Note 2)			PD	319	W
Continuous Drain Current (Notes 1, 2)	Steady State	T _C = 100°C	I _D	41	A
Power Dissipation (Notes 1, 2)			PD	160	W
Pulsed Drain Current (Note 3)	T _A = 25°C		I _{DM}	232	A
Single Pulse Surge Drain Current Capability	$\begin{array}{l} T_C = 25^\circ C, t_p = 10 \; \mu s, \\ R_G = 4.7 \; \Omega \end{array}$		I _{DSC}	416	A
Operating Junction and Storage Temperature Range			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			IS	32	А
Single Pulse Drain-to-Source Avalanche Energy ($I_{L(pk)} = 34 \text{ A}, L = 1 \text{ mH}$) (Note 4)		E _{AS}	578	mJ	
Maximum Lead Temperature for Soldering (1/8" from case for 5 s)		ΤL	300	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

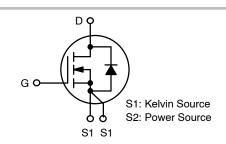
- 1. JA is constant value to follow guide table of LV/HV discrete final datasheet generation.
- 2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. 3. Repetitive rating, limited by max junction temperature.
- 4. EAS of 578 mJ is based on starting $T_J = 25^{\circ}C$; L = 1 mH, $I_{AS} = 34$ A, $V_{DD} = 120 \text{ V}, V_{GS} = 20 \text{ V}.$



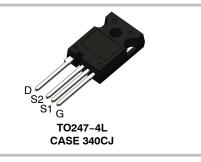
ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX		
1200 V	56 mΩ @ 20 V	58 A		



N-CHANNEL MOSFET



MARKING DIAGRAM



= Assembly Location Α

Υ = Year

WW = Work Week

ΖZ = Lot Traceability

NTH4L040N120SC1 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping		
NTH4L040N120SC1	TO247-4L	30 ea / Tube		

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter		Мах	Unit	
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	0.47	°C/W	
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{\theta JA}$	40		

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified)

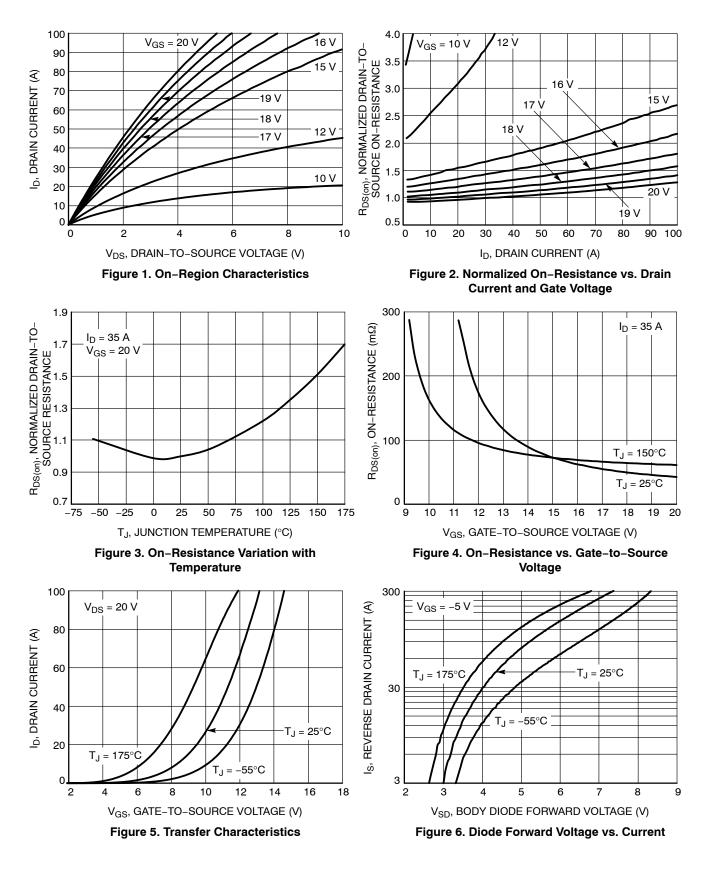
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS		•	•	•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 1 mA	1200	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 1 mA, referenced to 25°C) –	0.45	-	V/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$ $T_J = 2$.5°C –	-	100	μA
		V _{DS} = 1200 V T _J = 1	75°C –	-	1	mA
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = +25/-15 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	-	-	±1	μA
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 10 \text{ mA}$	1.8	3	4.3	V
Recommended Gate Voltage	V _{GOP}		-5	-	+20	V
Drain-to-Source On Resistance	R _{DS(on)}	V_{GS} = 20 V, I _D = 35 A, T _J = 25	5°C –	40	56	mΩ
		V_{GS} = 20 V, I_D = 35 A, T_J = 1	75°C –	70	100	
Forward Transconductance	9 _{FS}	$V_{DS} = 20 \text{ V}, \text{ I}_{D} = 35 \text{ A}$	-	20	-	S
CHARGES, CAPACITANCES & GATE RES	SISTANCE					
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 8	300 V –	1762	-	pF
Output Capacitance	C _{OSS}		-	137	-	
Reverse Transfer Capacitance	C _{RSS}		-	11	-	
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -5/20 \text{ V}, \text{ V}_{DS} = 600 \text{ V},$	-	106	-	nC
Threshold Gate Charge	Q _{G(TH)}	I _D = 47 A	-	16	-	
Gate-to-Source Charge	Q _{GS}	f = 1 MHz		34	-	
Gate-to-Drain Charge	Q _{GD}			26	-	
Gate-Resistance	R _G			2.4	-	Ω
SWITCHING CHARACTERISTICS, VGS =	10 V (Note 5)	•	•	•		
Turn–On Delay Time	t _{d(ON)}	$V_{GS} = -5/20 V,$	-	17	30	ns
Rise Time	t _r	$V_{DS}^{US} = 800 \text{ V},$ $I_{D} = 47 \text{ A},$	-	20	36	
Turn–Off Delay Time	t _{d(OFF)}	$R_{G} = 4.7 \Omega$ inductive load		32	51	
Fall Time	t _f	inductive local	-	10	20	
Turn–On Switching Loss	E _{ON}		-	411	-	μJ
Turn–Off Switching Loss	E _{OFF}		-	205	-	
Total Switching Loss	E _{tot}		-	616	-	
DRAIN-SOURCE DIODE CHARACTERIST	TICS	•	•	•	•	
Continuous Drain-Source Diode Forward Current	I _{SD}	V_{GS} = -5 V, T_{J} = 25°C	-	-	32	A
Pulsed Drain-Source Diode Forward Current (Note 3)	I _{SDM}		-	-	232	
Forward Diode Voltage	V _{SD}	V_{GS} = -5 V, I _{SD} = 17.5 A, T _J =	= 25°C –	3.7	-	V
Reverse Recovery Time	t _{RR}	$V_{GS} = -5/20 \text{ V}, I_{SD} = 47 \text{ A},$	-	24	-	ns
Reverse Recovery Charge	Q _{RR}	dl _S /dt = 1000 A/µs	-	124.8	-	nC

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified) (continued)

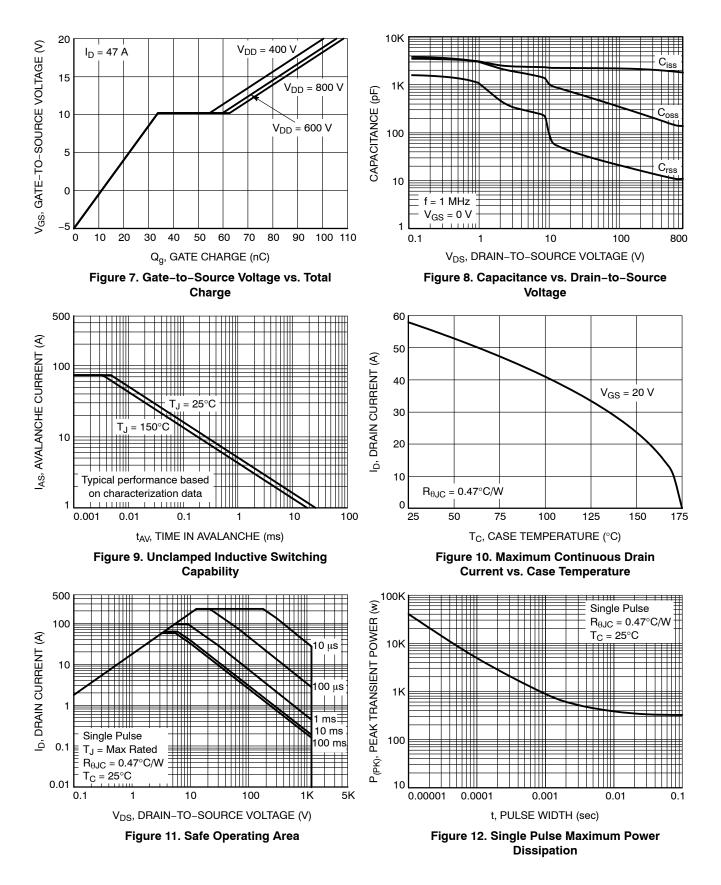
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
Reverse Recovery Energy	E _{REC}	$V_{GS} = -5/20 \text{ V}, I_{SD} = 47 \text{ A},$	-	8.4	-	μJ
Peak Reverse Recovery Current	I _{RRM}	dI _S /dt = 1000 A/µs	-	10.4	-	А
Charge time	Та		-	12.4	-	ns
Discharge time	Tb		-	11.6	-	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Switching characteristics are independent of operating junction temperature

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

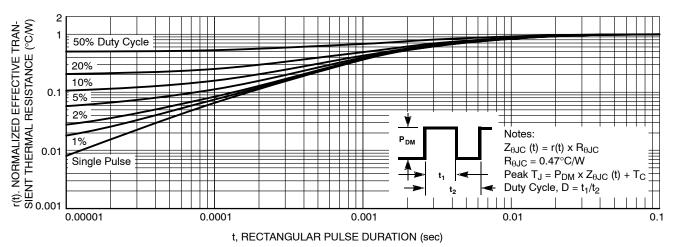
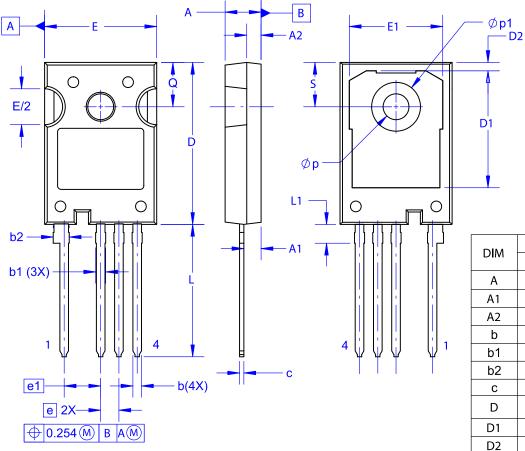


Figure 13. Junction-to-Ambient Thermal Response

PACKAGE DIMENSIONS

TO-247-4LD CASE 340CJ **ISSUE A**



NOTES:

A. NO INDUSTRY STANDARD APPLIES TO THIS PACKAGE.
B. DIMENSIONS ARE EXCLUSIVE OF BURRS,MOLD FLASH,AND TIE BAR EXTRUSIONS.
C. ALL DIMENSIONS ARE IN MILLIMETERS.
D. DRAWING CONFORMS TO ASME Y14.5-2009.

	1				
DIM	MILLIMETERS				
	MIN	NOM	MAX		
А	4.80	5.00	5.20		
A1	2.10	2.40	2.70		
A2	1.80	2.00	2.20		
b	1.07	1.20	1.33		
b1	1.20	1.40	1.60		
b2	2.02	2.22	2.42		
С	0.50	0.60	0.70		
D	22.34	22.54	22.74		
D1	16.00	16.25	16.50		
D2	0.97	1.17	1.37		
е	2	2.54 BSC	2		
e1	Ę	5.08 BSC	2		
Е	15.40	15.60	15.80		
E1	12.80	13.00	13.20		
E/2	4.80	5.00	5.20		
L	18.22	18.42	18.62		
L1	2.42	2.62	2.82		
р	3.40	3.60	3.80		
р1	6.60	6.80	7.00		
Q	5.97	6.17	6.37		
S	5.97	6.17	6.37		

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